

General Description

The GreenMOS® high voltage MOSFET utilizes charge balance technology to achieve outstanding low on-resistance and lower gate charge. It is engineered to minimize conduction loss, provide superior switching performance and robust avalanche capability.

The GreenMOS® Generic series is optimized for extreme switching performance to minimize switching loss. It is tailored for high power density applications to meet the highest efficiency standards.

Features

- Low $R_{DS(ON)}$ & FOM
- Extremely low switching loss
- Excellent stability and uniformity



Applications

- PC power
- LED lighting
- Telecom power
- Server power
- EV Charger
- Solar/UPS

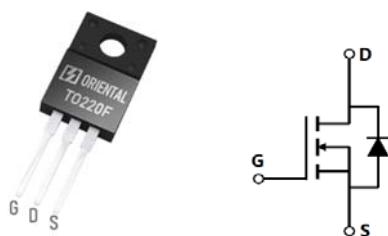
Key Performance Parameters

Parameter	Value	Unit
V_{DS} , min @ $T_{j(max)}$	600	V
I_D , pulse	120	A
$R_{DS(ON)}$, max @ $V_{GS}=10V$	92	mΩ
Q_g	38.6	nC

Marking Information

Product Name	Package	Marking
OSG55R092FF	TO220F	OSG55R092F

Package & Pin Information



Absolute Maximum Ratings at $T_j=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	550	V
Gate-source voltage	V_{GS}	± 30	V
Continuous drain current ¹⁾ , $T_c=25^\circ\text{C}$	I_D	40	A
Continuous drain current ¹⁾ , $T_c=100^\circ\text{C}$		25	
Pulsed drain current ²⁾ , $T_c=25^\circ\text{C}$	$I_{D, \text{pulse}}$	120	A
Continuous diode forward current ¹⁾ , $T_c=25^\circ\text{C}$	I_S	40	A
Diode pulsed current ²⁾ , $T_c=25^\circ\text{C}$	$I_{S, \text{pulse}}$	120	A
Power dissipation ³⁾ , $T_c=25^\circ\text{C}$	P_D	34	W
Single pulsed avalanche energy ⁵⁾	E_{AS}	770	mJ
MOSFET dv/dt ruggedness, $V_{DS}=0\dots 480\text{ V}$	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS}=0\dots 480\text{ V}$, $I_{SD} \leq I_D$	dv/dt	15	V/ns
Operation and storage temperature	T_{stg}, T_j	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal resistance, junction-case	$R_{\theta JC}$	3.7	°C/W
Thermal resistance, junction-ambient ⁴⁾	$R_{\theta JA}$	62.5	°C/W

Electrical Characteristics at $T_j=25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Drain-source breakdown voltage	BV_{DSS}	550			V	$V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$
		600	670			$V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$, $T_j=150^\circ\text{C}$
Gate threshold voltage	$V_{GS(\text{th})}$	2.9		3.9	V	$V_{DS}=V_{GS}$, $I_D=1\text{ mA}$
Drain-source on-state resistance	$R_{DS(\text{ON})}$		0.078	0.092	Ω	$V_{GS}=10\text{ V}$, $I_D=20\text{ A}$
			0.183			$V_{GS}=10\text{ V}$, $I_D=20\text{ A}$, $T_j=150^\circ\text{C}$
Gate-source leakage current	I_{GSS}			100	nA	$V_{GS}=30\text{ V}$
				-100		$V_{GS}=-30\text{ V}$
Drain-source leakage current	I_{DSS}			1	μA	$V_{DS}=550\text{ V}$, $V_{GS}=0\text{ V}$

Dynamic Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Input capacitance	C _{iss}		2425.5		pF	V _{GS} =0 V, V _{DS} =50 V, f=100 kHz
Output capacitance	C _{oss}		244.3		pF	
Reverse transfer capacitance	C _{rss}		10.3		pF	
Turn-on delay time	t _{d(on)}		53.7		ns	V _{GS} =10 V, V _{DS} =400 V, R _G =2 Ω, I _D =20 A
Rise time	t _r		79.3		ns	
Turn-off delay time	t _{d(off)}		122.9		ns	
Fall time	t _f		59.1		ns	

Gate Charge Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Total gate charge	Q _g		38.6		nC	V _{GS} =10 V, V _{DS} =400 V, I _D =20 A
Gate-source charge	Q _{gs}		9		nC	
Gate-drain charge	Q _{gd}		15.2		nC	
Gate plateau voltage	V _{plateau}		5.9		V	

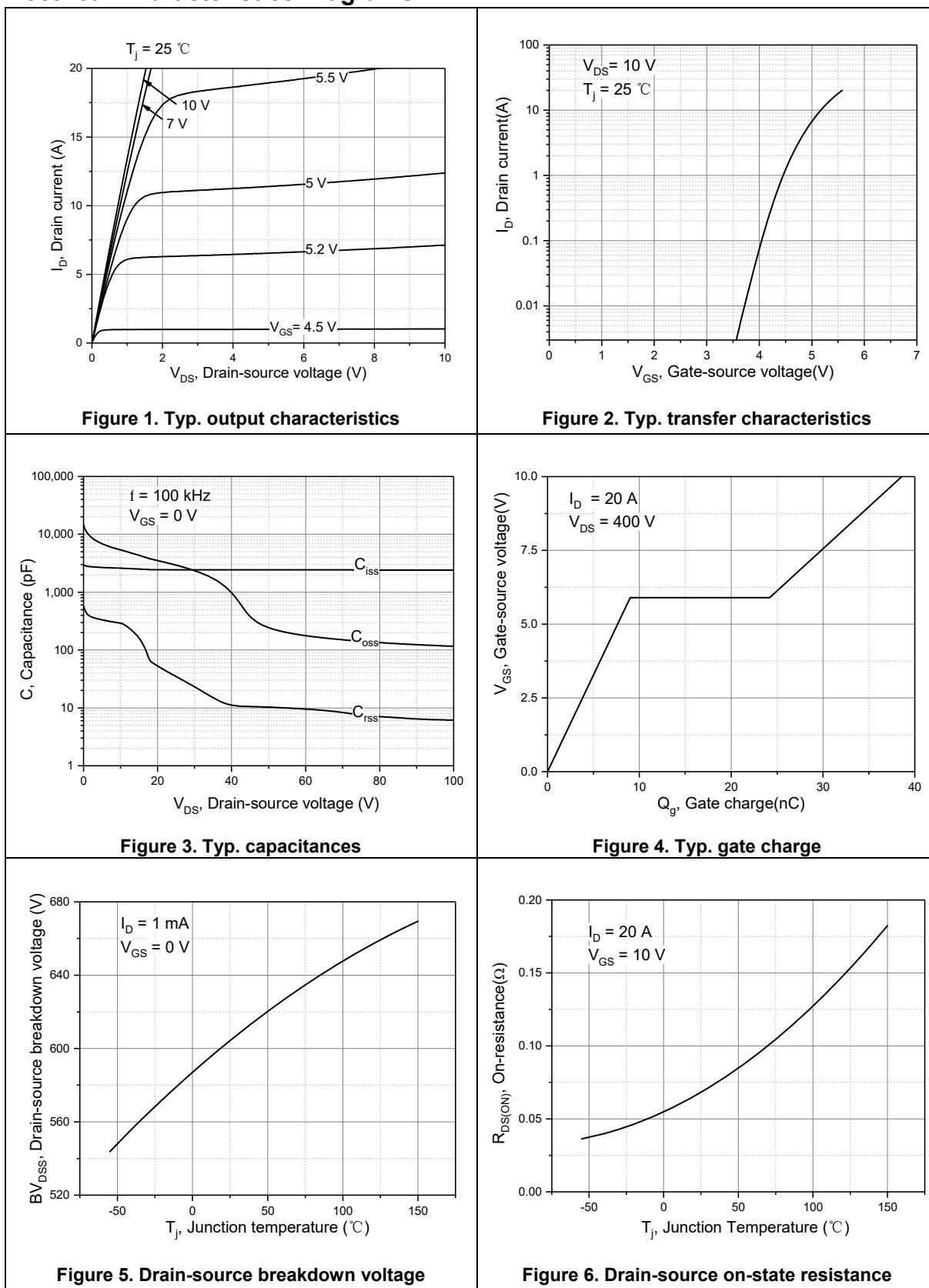
Body Diode Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Diode forward voltage	V _{SD}			1.4	V	I _S =40 A, V _{GS} =0 V
Reverse recovery time	t _{rr}		339		ns	V _R =400 V, I _S =20 A, di/dt=100 A/μs
Reverse recovery charge	Q _{rr}		4.9		μC	
Peak reverse recovery current	I _{rrm}		27.9		A	

Note

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3) Pd is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of R_{θJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_a=25 °C.
- 5) V_{DD}=100 V, V_{GS}=10 V, L=10 mH, starting T_j=25 °C.

Electrical Characteristics Diagrams



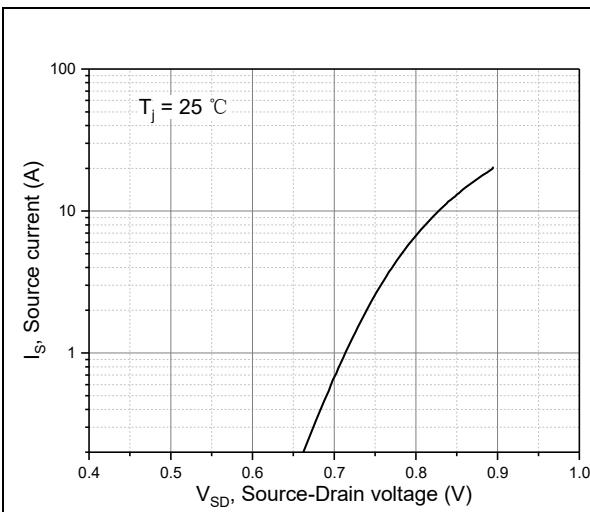


Figure 7. Forward characteristic of body diode

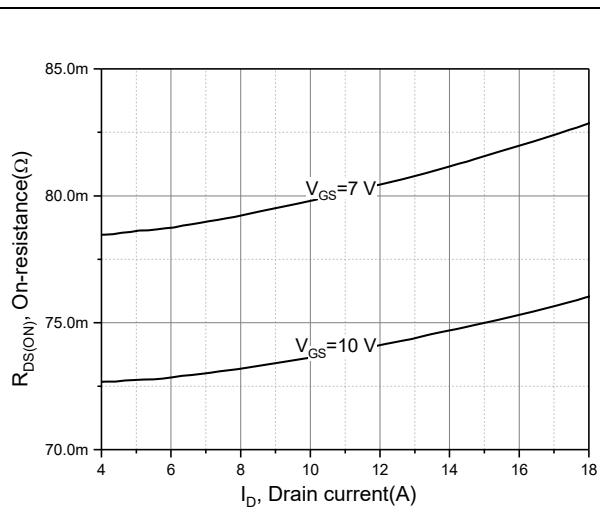


Figure 8. Drain-source on-state resistance

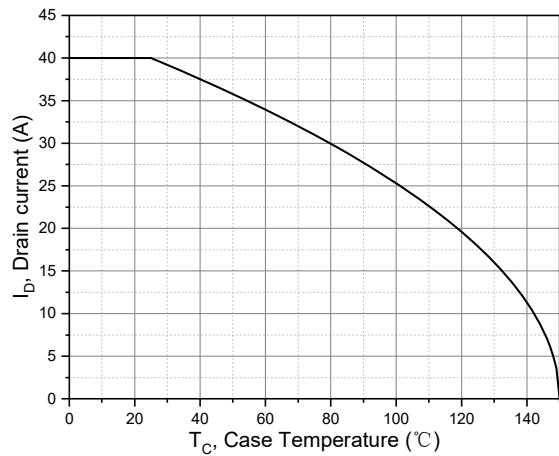


Figure 9. Drain current

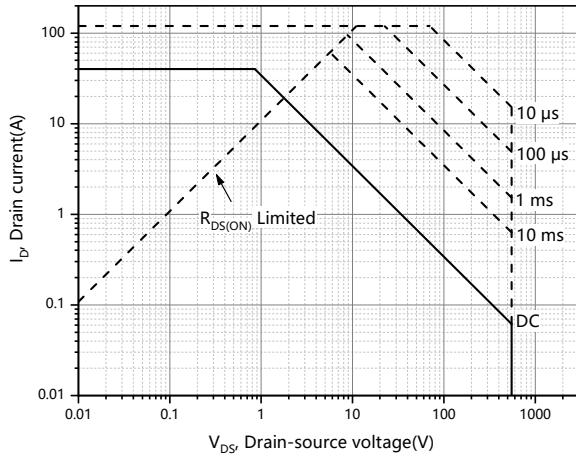
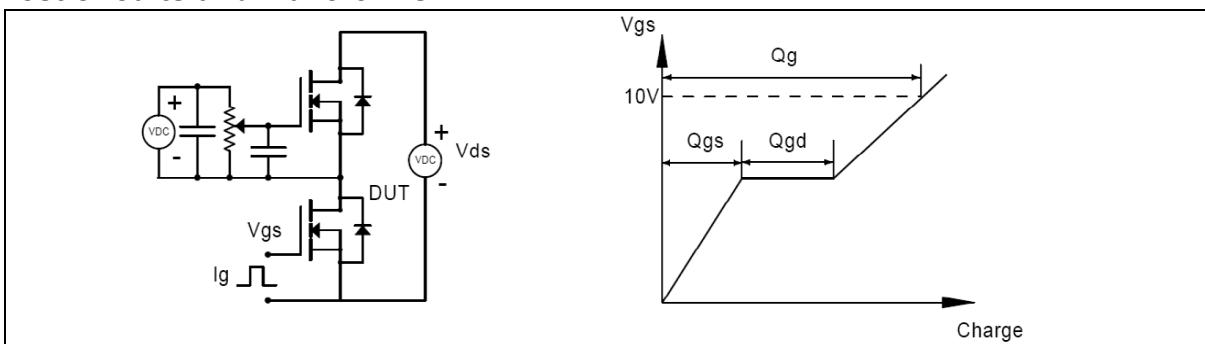
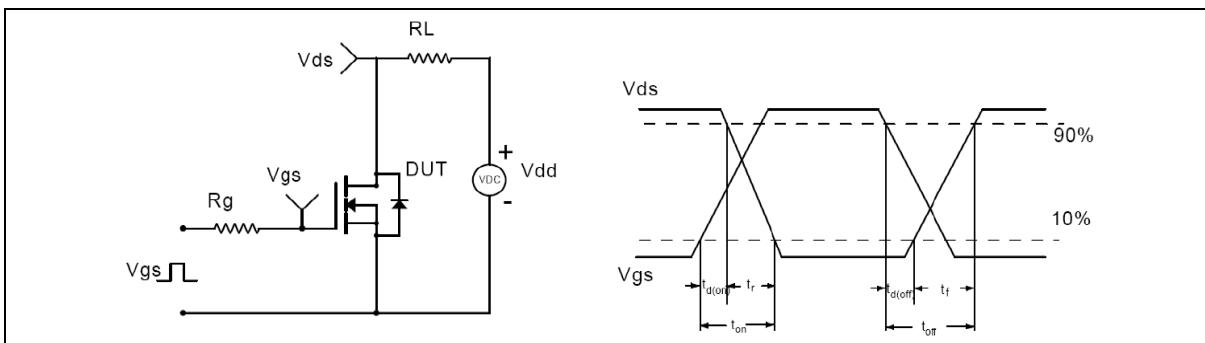
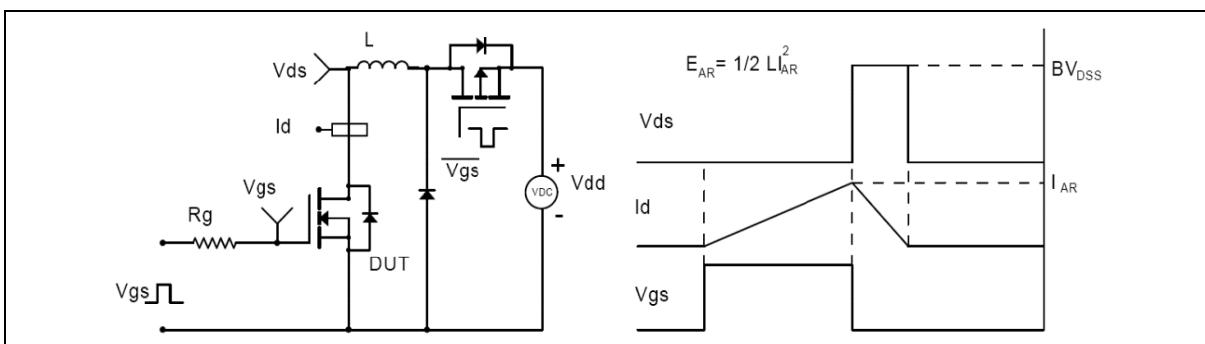
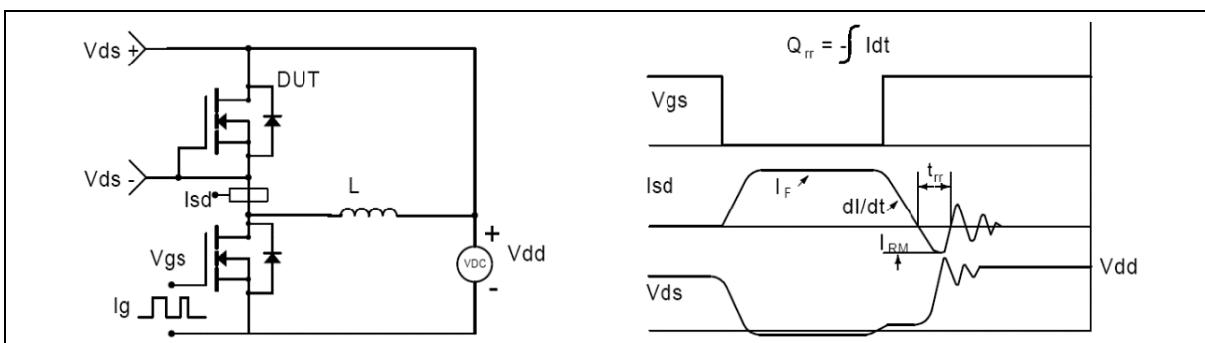
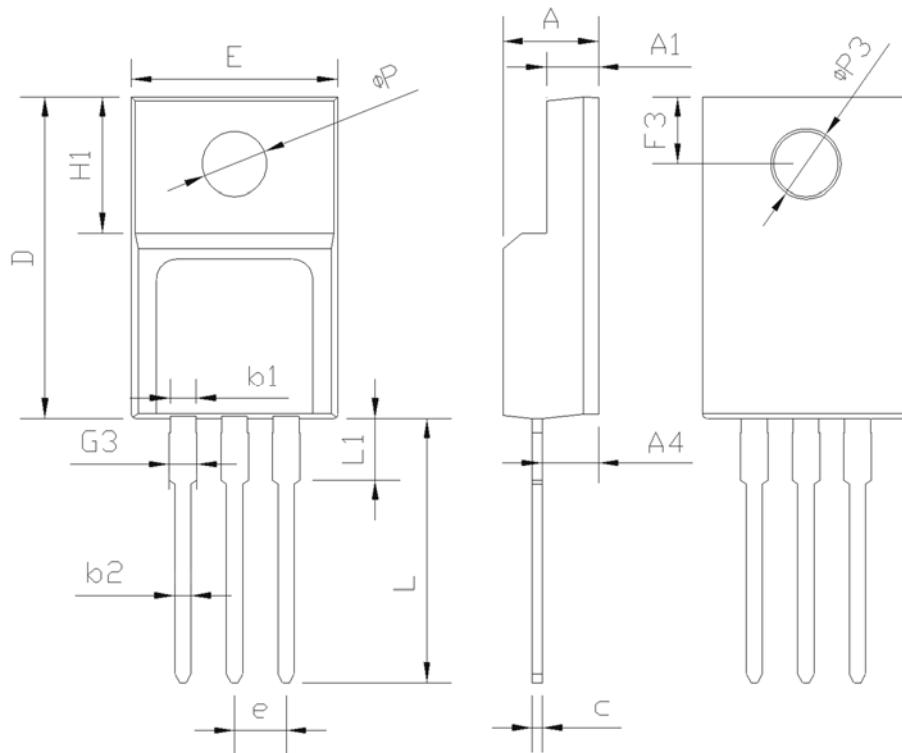


Figure 10. Safe operation area $T_c=25\text{ }^{\circ}\text{C}$

Test circuits and waveforms

Figure 1. Gate charge test circuit & waveform

Figure 2. Switching time test circuit & waveforms

Figure 3. Unclamped inductive switching (UIS) test circuit & waveforms

Figure 4. Diode reverse recovery test circuit & waveforms

Package Information



Symbol	mm		
	Min	Nom	Max
E	9.96	10.16	10.36
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A4	2.56	2.76	2.96
c	0.40	0.50	0.65
D	15.57	15.87	16.17
H1	6.70 REF		
e	2.54 BSC		
L	12.68	12.98	13.28
L1	2.88	3.03	3.18
ΦP	3.03	3.18	3.38
ΦP3	3.15	3.45	3.65
F3	3.15	3.30	3.45
G3	1.25	1.35	1.55
b1	1.18	1.28	1.43
b2	0.70	0.80	0.95

Version 1:TO220F-C package outline dimension

Ordering Information

Package Type	Units/Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
TO220F-C	50	20	1000	6	6000

Product Information

Product	Package	Pb Free	RoHS	Halogen Free
OSG55R092FF	TO220F	yes	yes	yes

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